

RoHS

Compliant



Features:

- Standard type of V-chip, 2,000 hours, 105°C
- Applicable to SMT process. •

Specifications:

Items	Characteristics									
Capacitance Tolerance	± 20%(120Hz, 20°C)									
Operating Temperature Range	-55°C to +105°C									
Rated Voltage Range	6.3 to 50V DC									
Capacitance Range	0.1 to 1,000µF									
Leakage Current	$I \leq 0.03 CV$ or 3 (µA), which is greater. (After 2 minutes application of DC rated voltage, at 20°C)									
	Measurement Frequency: 120Hz. Temperature: 20°C									
Dissipation Factor (tan δ)	Rated Voltage(V)	6.3	10	16	25	35	50			
	tan δ(Max)	0.32	0.28	0.24	0.18	0.15	0.14			
	Measurement Frequency: 1	20Hz.								
Low Temperature Stability	Rated Voltage(V)	6.3	10	16	25	35	50			
Impedance Ratio(Max)	Z(-25°C)/Z(20°C)	4	3	2	2	2	2			
	Z(-55°C)/Z(20°C)	8	8	4	4	3	3			
Load Life	2000 hours,with application of rated voltage at 105°C Capacitance Change Within ±20% of Initial Value tan δ 200% or less of Initial Specified Value Leakage Current Initial Specified Value or less									
Shelf Life	The following specifications shall be satisfied when the capacitors are restored to 20°C after exposing them for 1,000 hours 105°C without voltage applied. Before the measurement, the capacitor shall be preconditioned by applying voltage according to them 4.1 of JIS C5101-4.									
	Capacitance Change	Within ± 2	20% of Initia	al Value						
	tan δ 200% or less of Initial Specified Value									
	Leakage Current Initial Specified Value or less									
	The capacitors shall be kep maintained at 250°C for 30	Capacitance Within ± 10% Change of Initial Value								
Resistance to Soldering Heat	After removing from the hot	After removing from the hot plate and restored at			an δ Initial Specified Value					
	room temperature they mee requirements listed at right.	Leakage Initial Specified Value o Current less			Value or					
Marking	Black print on the case top									



Frequency Coefficient of Permissible Ripple Current

Frequency (Hz)	50	120	300	1K	≧10K
Coefficient	0.7	1	1.17	1.36	1.5

The endurance of capacitors is reduced with internal heating produced by ripple current at the rate of halving the lifetime with every 5°C rise. When long life performance is required in actual use , the rms ripple current has to be reduced.

Scope

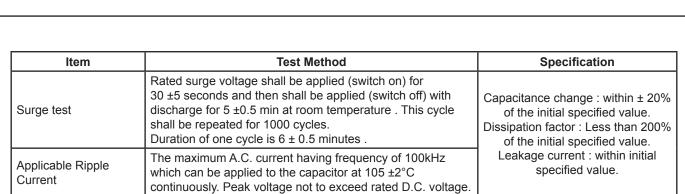
This specification applies to aluminium electrolytic capacitor, used in electronic equipment.

Electrical Characteristics

Item		Те	est Method		Specification
Rated Voltage					Voltage range, capacitance range, see specification of this series.
Capacitance		0 1 5	20 ±12Hz ≦0.5Vrms + 0.5 ~	2\/DC	Voltage range, capacitance range, see specification of this series.
Dissipation factor		0 0		2100	Dissipation factor, leakage current, see specification of this series.
Leakage current	application 1000Ω reference of the second secon	ge current shall h on of the DC rated sistor at 20°C	Dissipation factor leakage current, see specification of this series.		
	Step	Temperature	Storage Time]	
	1	20 ±2°C	30 minutes		
	2	-40 ±3°C	2 hours		Step 2. Impedance ratio (Zr / Zr0)
	3	20 ±2°C	15 minutes		less than specified value. Step 4. Capacitance change :
Temperature	4	105 ±2°C	2 hours		within ± 20% of the initial
characteristics	(Step 2. M 2 (Step 4. M	leasure the capa Z , 20°C , 120Hz leasure the impe hours. Z , 20°C , 120Hz leasure the capa hermal balance a	measured value. Leakage current : Less than 10 times of initial specified value .		



SMD Aluminium Electrolytic Capacitors multicomp



Mechanical characteristics

	(A) Tensile str	ength :							
	wire lead t	erminal :							
	d (mm) ≦0.45 0.5 ~ 0.8 0		0.8 <d td="" ≦1.25<=""><td colspan="3"></td></d>						
	Load (kg)	0.51	1	2					
	Snap-in termi	nal		_					
	d (mm) snap-in terminal								
	Load (kg)		2	J					
	The capacitor specified betw without damag (B) Bending s wire lead t	veen the boo ge either me trength :	When the capacitance is measured, there shall be no intermittent contacts, or open- or						
Lead strength	d (mm)	≦0.45	0.5 ~ 0.8	0.8 <d td="" ≦1.25<=""><td></td><td colspan="3">short-circuiting.</td></d>		short-circuiting.			
	Load (kg)	0.25	0.51	1		There shall be no such mechanical damage as terminal damage etc.			
	Snap-in termi	nal	damage as terminal damage etc.						
	Cross section	n area of te	rminal	Force (kg)					
	0.	5 <s≦1< td=""><td></td><td>1</td><td></td><td></td></s≦1<>		1					
		S>1		2.5					
	With the capa specified axia slowly from th vertical position the original po- changed and	lly to each le e vertical to on. The 90° osition. Perfe							
Vibration resistance	The frequency range 10 to 55 the cycle in th The capacitor hold the body in three mutua hours in each	5 Hz with the e internal of shall be see of capacitor ally perpend	e amplitude fone minute curely mour r. The capad	oleting with rated	Capacitance : no unsteady. Appearance : no abnormal. Capacitance change : within ±5% of initial measured value .				
Solderability	The leads are for 2 ±0.5 sec at 1.5 ~ 2mm	onds . The o	The solder alloy shall cover the 95% or more of the dipped lead's area .						



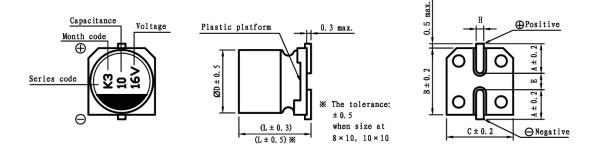
Reliability

Item	Test Method	Specification
Soldering heat resistance	The leads immerse in the solder bath of Sn at 260 \pm 5°C for 10 \pm 1 seconds until a distance of 1.5 ~ 2mm from the case.	No damage or leakage of electrolyte. Capacitance change : within ± 10% of the initial measured value. Tan δ : less than specified value. Leakage current : less than speci- fied value.
Damp heat (Steady state)	Subject the capacitors to 40 \pm 2°C and 90% to 95% relative humidity for 240 \pm 8 hours.	Capacitance change : within ±10% of the initial measured value. Tan δ : less than specified value. Leakage current : less than specified value.
Load life	After X hours continuous application of DC rated working voltage at $105 \pm 2^{\circ}$ C, the measurements shall meet the following limits. Measurements shall be performed after 2 hours exposed at room temperature.	Standard of judgement is
Shelf life	After storage for Y hours at 105 $\pm 2^{\circ}$ C without voltage application, the measurements shall meet the following limits. Measurements shall be performed after exposed for 1 to 2 hrs at room temperature after application of DC rated voltage to the capacitor for Z minutes.	according to requirement of this series.
Storage at Low Temperature	The capacitor shall be stored at temperature of $-40 \pm 3^{\circ}$ C for 240 ±8 hours, during which time no voltage shall be applied. And then the capacitor shall be subjected to standard atmospheric conditions for 16 hours or more, after which measurements shall be made.	Capacitance change : within ±10% of the initial value. Tan δ : less than specified value. Leakage current : less than speci- fied value Appearance : no abnormal.

MCVFZ Series

Dimensions:

Chip Type





D × L	4 × 5.4	5 × 5.4	6.3 × 5.4	6.3 × 7.7	8 × 10	10 × 10
A	1.8	2.1	2.4	2.4	2.9	3.2
В	4.3	5.3	6.6	6.6	8.3	10.3
С	4.3	5.3	6.6	6.6	8.3	10.3
E	1.0	1.3	2.2	2.2	3.1	4.5
L	5.4	5.4	5.4	7.7	10	10
Н	0.5~0.8	0.5~0.8	0.5~0.8	0.5~0.8	0.8~1.1	0.8~1.1

Dimensions : Millimetres

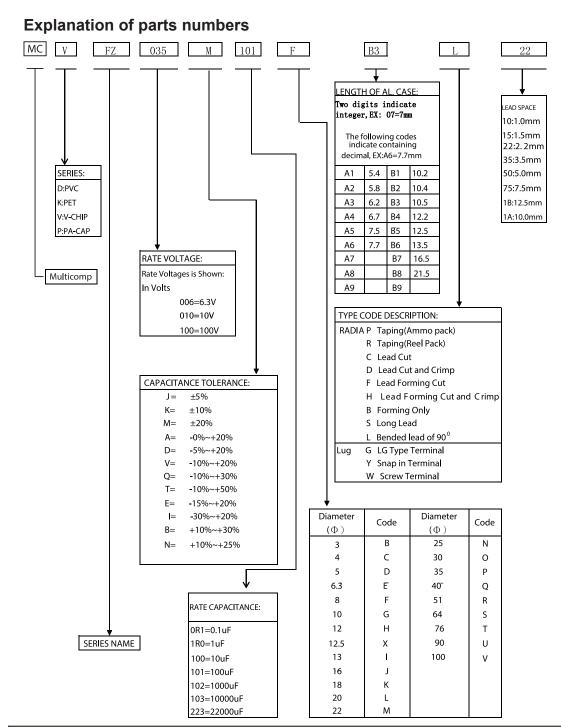
Standard Ratings:

D × L (mm); R.C.(mA rms) at 105°C 120Hz.

Cap	V (Code)	6.3 (0J		10 (1A		16 (10		25 (1E		35 (1V)		50 (1H)	
(µF)	Item	D×L	R.C.	D×L	R.C.	D×L	R.C.	D×L	R.C.	D×L	R.C.	D×L	R.C.
0	.1	-	-	-	-	-	-	-	-	-	-	4×5.4	1
0.	22	-	-	-	-	-	-	-	-	-	-	4×5.4	2.6
0.	33	-	-	-	-	-	-	-	-	-	-	4×5.4	3.2
0.	47	-	-	-	-	-	-	-	-	-	-	4×5.4	3.8
	1	-	-	-	-	-	-	-	-	-	-	4×5.4	8
2	.2	-	-	-	-	-	-	4×5.4	6.6	4×5.4	8	4×5.4	11
3	.3	-	-	-	-	4×5.4	7	4×5.4	12	4×5.4	13	4×5.4	16
4	.7	-	-	4×5.4	7	4×5.4	9	4×5.4	13	4×5.4	15	5×5.4	19
1	0	4×5.4	10	4×5.4	13	4×5.4	28	5×5.4	25	5×5.4	28	6.3×5.4	35
2	22	4×5.4	26	5×5.4	35	5×5.4	39	6.3×5.4	45	6.3×5.4	70	6.3×7.7	58
3	33	4×5.4	29	6.3×5.4	43	6.3×5.4	51	6.3×5.4	65	6.3×5.4	70	8×10	140
1	7	5×5.4 45	C 245 4	62	6 2 × 5 4	6.3×5.4	70	6.3×5.4	70	6.3×7.7	80	8×10	170
-	F7	5^5.4	40	6.3×5.4	02	0.3^5.4	70	6.3×7.7	80	0.3^7.7	00		170
1(00	6.3×5.4	71	6.3×5.4	90	6.3×7.7	100	6.3×7.7	100	8×10	305	8×10	315
24	20	6.3×7.7	100	6.3×7.7	120	6.3×7.7	125	8×10	355	10×10	450	10×10	450
24	20	0.3^7.7	100	0.3^7.7	120	0 8×10 2	215	0^10	300	10~10	450	10^10	430
33	30			8×10	215	10×10	440	10×10	450	-	-	-	-
4	70	10×10	310	10×10	440	10×10	460	10×10	490	-	-	-	-
10	000	10×10	495	-	-	-	-	-	-	-	-	-	-



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